

Failure analysis

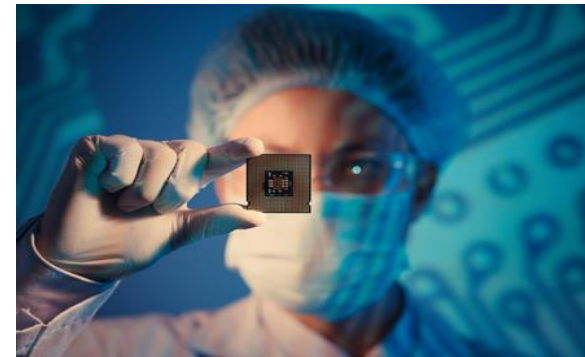
Failure analysis service

◆ Outline of failure analysis

Through-out service from characteristics evaluation through physical analysis with only IC specifications, a test board, and a test program.

Accumulated expertise in analysis equipment and failure estimation (pointing-out of defect area) help realize short TAT and 80% or more failure part elucidation rate.

- Primary report : less than 5 days
- Elucidation rate : 80% or more
- Product type : logic/analog/memory
- Support of every tester, analysis equipment
- Consistent analysis from characteristics evaluation through physical analysis



◆ Analysis solutions

- Upon request for semiconductor failure analysis, consistent analysis solutions:
characteristics evaluation -> non-destructive analysis -> specifying failure part -> physical analysis
- Upon request for operation failure analysis, tester-linked analysis solutions by direct docking of the tester and analysis equipment
- Upon request for yield improvement, consistent response:
evaluation -> analysis -> improvement consulting service
- Failure analysis through ultimate narrowing down of defect area